

## APT97N65B2C6 APT97N65LC6

650V 97A  $0.041\Omega$ 



# **Super Junction MOSFET**

APT97N65B2C6







• Ultra Low R<sub>DS(ON)</sub>

• Low Miller Capacitance

• Ultra Low Gate Charge, Q<sub>q</sub>

· Avalanche Energy Rated

Extreme dv/dt Rated

Unless stated otherwise, Microsemi discrete MOSFETs contain a single MOSFET die. This device is made with two parallel MOSFET die. It is intended for switch-mode operation. It is not suitable for linear mode operation.

#### All Ratings per die: $T_C = 25^{\circ}C$ unless otherwise specified. **MAXIMUM RATINGS**

Symbol	Parameter	APT97N65B2_LC6	UNIT
V <sub>DSS</sub>	Drain-Source Voltage	650	Volts
	Continuous Drain Current @ $T_C = 25^{\circ}C^{-1}$ (assuming Rdson max = 0.041 $\Omega$ )	97	
I <sub>D</sub>	Continuous Drain Current @ T <sub>C</sub> = 100°C	62	Amps
I <sub>DM</sub>	Pulsed Drain Current <sup>2</sup>	291	
$V_{GS}$	Gate-Source Voltage Continuous	±20	Volts
$P_{D}$	Total Power Dissipation @ T <sub>C</sub> = 25°C	862	Watts
$T_J, T_STG$	Operating and Storage Junction Temperature Range	-55 - to 150	°C
T <sub>L</sub>	Lead Temperature: 0.063" from Case for 10 Sec.	260	C
I <sub>AR</sub>	Avalanche Current <sup>2</sup>	13.4	Amps
E <sub>AR</sub>	Repetitive Avalanche Energy <sup>3</sup> (Id = 13.4A, Vdd = 50V)	2.96	
E <sub>AS</sub>	Single Pulse Avalanche Energy ( Id = 13.4A, Vdd = 50V )	1954	mJ

#### STATIC ELECTRICAL CHARACTERISTICS

Symbol	Characteristic / Test Conditions	MIN	TYP	MAX	UNIT
BV <sub>(DSS)</sub>	Drain-Source Breakdown Voltage (V <sub>GS</sub> = 0V, I <sub>D</sub> = 250μA)	650			Volts
R <sub>DS(on)</sub>	Drain-Source On-State Resistance <sup>4</sup> (V <sub>GS</sub> = 10V, I <sub>D</sub> = 48.5A)		0.037	0.041	Ohms
I <sub>DSS</sub>	Zero Gate Voltage Drain Current (V <sub>DS</sub> = 650V, V <sub>GS</sub> = 0V)			25	
	Zero Gate Voltage Drain Current (V <sub>DS</sub> = 650V, V <sub>GS</sub> = 0V, T <sub>C</sub> = 150°C)			250	μA
I <sub>GSS</sub>	Gate-Source Leakage Current (V <sub>GS</sub> = ±20V, V <sub>DS</sub> = 0V)			±100	nA
V <sub>GS(th)</sub>	Gate Threshold Voltage (V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 2.96mA)	2.5	3	3.5	Volts

CAUTION: These Devices are Sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed.

Symbol	Characteristic	Test Conditions	MIN	TYP	MAX	UNIT
C <sub>iss</sub>	Input Capacitance	V <sub>GS</sub> = 0V		7650		
C <sub>oss</sub>	Output Capacitance	$V_{DS} = 25V$		5045		pF
C <sub>rss</sub>	Reverse Transfer Capacitance	f = 1 MHz		550		
$Q_g$	Total Gate Charge <sup>⑤</sup>	V <sub>GS</sub> = 10V		300		nC
Q <sub>gs</sub>	Gate-Source Charge	$V_{GS} = 10V$ $V_{DD} = 325V$ $I_{D} = 97A @ 25^{\circ}C$		50		
Q <sub>gd</sub>	Gate-Drain ("Miller") Charge	I <sub>D</sub> = 97A @ 25°C		160		
t <sub>d(on)</sub>	Turn-on Delay Time	INDUCTIVE SWITCHING $V_{GS} = 15V$ $V_{DD} = 433V$ $I_{D} = 97A @ 25^{\circ}C$ $R_{G} = 2.2\Omega$		25		
t <sub>r</sub>	Rise Time			60		
$t_{d(off)}$	Turn-off Delay Time			275		ns
t <sub>f</sub>	Fall Time			130		
E <sub>on</sub>	Turn-on Switching Energy <sup>®</sup>	INDUCTIVE SWITCHING @ 25°C		2860		
E <sub>off</sub>	Turn-off Switching Energy	$V_{DD} = 433V, V_{GS} = 15V$ $I_{D} = 97A, R_{G} = 2.2\Omega$		3500		
E <sub>on</sub>	Turn-on Switching Energy ®	INDUCTIVE SWITCHING @ 125°C $V_{DD} = 433V$ , $V_{GS} = 15V$ $I_{D} = 97A$ , $R_{G} = 2.2\Omega$		4030		μJ
E <sub>off</sub>	Turn-off Switching Energy			3695		

#### SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS

Symbol	Characteristic / Test Conditions		MIN	TYP	MAX	UNIT
Is	Continuous Source Current (Body Diode)				97	Amno
l <sub>sm</sub>	Pulsed Source Current <sup>②</sup> (Body Diode)				291	Amps
$V_{_{\mathrm{SD}}}$	Diode Forward Voltage 4 (V <sub>GS</sub> = 0V, I <sub>S</sub> = -48.5A)			0.9	1.2	Volts
dv/ <sub>dt</sub>	Peak Diode Recovery dv/dt				50	V/ns
t <sub>rr</sub>	Reverse Recovery Time $(I_S = -97A, di/dt = 100A/\mu s)$	T <sub>j</sub> = 25°C		790		ns
Q <sub>m</sub>	Reverse Recovery Charge $(I_S = -97A, dI/dt = 100A/\mu S)$	T <sub>j</sub> = 25°C		19		μC
I <sub>RRM</sub>	Peak Recovery Current (I <sub>S</sub> = -97A, <sup>di</sup> / <sub>dt</sub> = 100A/µs)	T <sub>j</sub> = 25°C		43		Amps

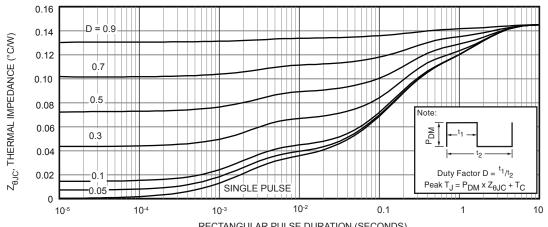
### THERMAL CHARACTERISTICS

Symbol	Characteristic	MIN	TYP	MAX	UNIT
$R_{\scriptscriptstyle{ hetaJC}}$	Junction to Case			0.145	°C/W
R	Junction to Ambient			40	

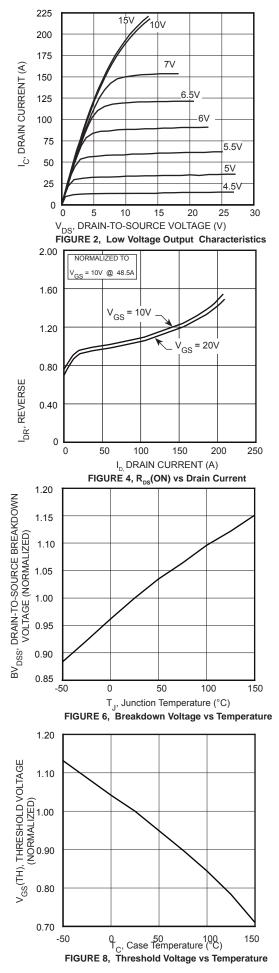
- 1 Continuous current limited by package lead temperature.
- 2 Repetitive Rating: Pulse width limited by maximum junction temperature
- 3 Repetitive avalanche causes additional power losses that can be calculated as 6 Eon includes diode reverse recovery.
- $P_{AV} = E_{AR}^* f$ . Pulse width tp limited by Tj max.

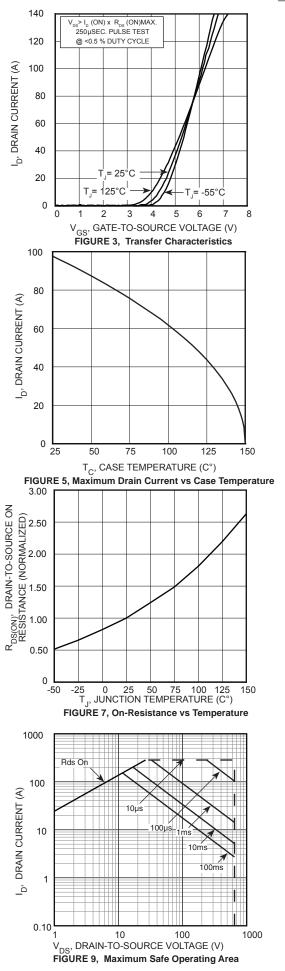
- 4 Pulse Test: Pulse width < 380  $\mu$ s, Duty Cycle < 2%
- 5 See MIL-STD-750 Method 3471
- 7 Maximum 125°C diode commutation speed = di/dt 600A/µs

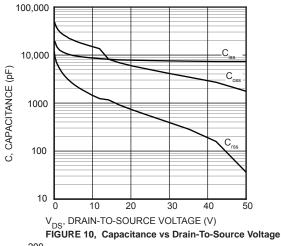
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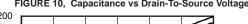


RECTANGULAR PULSE DURATION (SECONDS)
Figure 1, Maximum Effective Transient Thermal Impedance, Junction-To-Case vs Pulse Duration









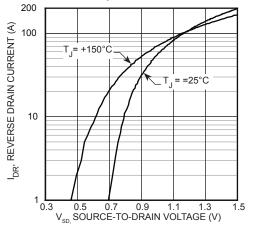


FIGURE 12, Source-Drain Diode Forward Voltage

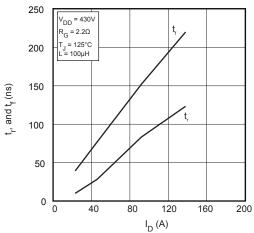


FIGURE 14, Rise and Fall Times vs Current

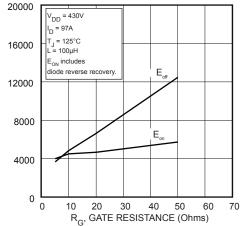
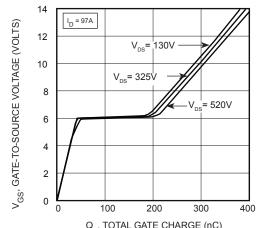


FIGURE 16, Switching Energy vs Gate Resistance



 $\rm Q_g, TOTAL\ GATE\ CHARGE\ (nC)$  FIGURE 11,  $\,$  Gate Charges vs Gate-To-Source Voltage

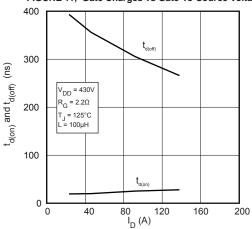
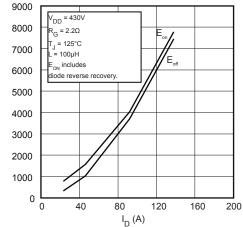


FIGURE 13, Delay Times vs Current



SWITCHING ENERGY (µJ)

FIGURE 15, Switching Energy vs Current

SWITCHING ENERGY (uJ)

### **Typical Performance Curves**

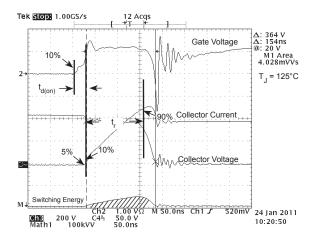


Figure 17, Turn-on Switching Waveforms and Definitions

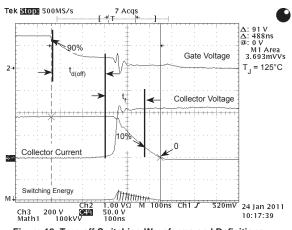


Figure 18, Turn-off Switching Waveforms and Definitions

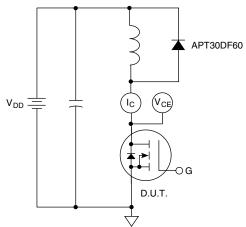


Figure 19, Inductive Switching Test Circuit

## T-MAX® (B2) Package Outline

### TO-264 (L) Package Outline

